

**Search Notes**

Application/Control No.

10/516,365

Examiner

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Applicant(s)/Patent under  
Reexamination

YOSHII ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	297	8/7/2007	JP
455	63.1	8/2/2007	JP
	67.13	8/2/2007	JP
	115.1-115	8/2/2007	JP
	127.1	8/2/2007	JP
	127.2	8/2/2007	JP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East USPAT/USPGPUB	8/2/2007	JP
Inventor Name Search EAST/EDAN	8/2/2007	JP